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			EXAMINER LIN, PHYOWAI	
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Summary	Application No. 10/803,988	Applicant(s) KIM ET AL.	
	Examiner PHYOWAI LIN	Art Unit 2613	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☐ Responsive to communication(s) filed on ____.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-20 is/are pending in the application.
- 4a) Of the above claim(s) 7 is/are withdrawn from consideration.
- 5) ☐ Claim(s) ____ is/are allowed.
- 6) ☒ Claim(s) 1-19 (formal claims 1-6 and 8-20) is/are rejected.
- 7) ☐ Claim(s) ____ is/are objected to.
- 8) ☐ Claim(s) ____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 19 March 2004 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. ____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|--|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. ____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)
Paper No(s)/Mail Date ____ | 6) <input type="checkbox"/> Other: ____ |

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

2. **Claim 1,3,4,6,8-11,13-18 and 20** are rejected under 35 U.S.C. 102(b) as being anticipated by Ido et al. (US Pub Number 2002/0181853).

Regarding to claim 1, Ido et al. discloses an optical transceiver (see [0114] lines 2 and FIG.19), comprising:

a photoelectric transducer (LD module-see [0019] line 1 and FIG. 2) implemented on a substrate (a silicon sub-mount 8-see [0050] line2 and FIG. 2) and having a light transmitting device (a laser diode(LD) element 9-see [0048] line 2 and FIG.2) for converting an electrical signal into a light signal (see [0048] line 2-3) , a high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device, a bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device spaced from the high speed signal line for the light transmitting device (see FIG.2 where in the electrode pattern 3-11 has space from the microstrip line 39 for transmitting device), a light receiving device (PD element 10-see [0079] line 3 and FIG.9) for converting the light signal into the electrical signal (see [0079] lines 1-3) , a high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device, a bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9)

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for the light receiving device spaced from the high speed signal line for the light receiving device (see FIG.9 where in the electrode pattern 3-12 has space from the strip line 39 for receiving device), a first dummy ground line (ground pin 6-3-see [0049] line16 and FIG.2) located adjacent to the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device, and a second dummy ground line (lead 6-4-see [0079] line 8 and FIG.9) located adjacent to the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device;

wherein the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) is less than or equal to the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the distance between a microstrip line 3-9 and ground pin 6-1 is smaller than the distance between a microstrip line 3-9 and electrode pattern 3-11); and the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) is less than or equal to the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which the distance between a strip line 3-9 and lead 6-2 is smaller than the distance between the perimeter of a strip line 3-9 and the electrode pattern 3-12) and

a light signal transmitter (a LD driver IC 112-see [0114] line 7 and FIG.19) connected to the photoelectric transducer (a LD module-see [0114] line 2 and FIG.19), transmitting a light signal received from an optical fiber to the light receiving device (see [0114] lines 13-17 in which light transmits from LD module which enters into the fiber first and then is received by PD module), and transmitting a light signal generated from the light transmitting device to the optical fiber (see [0014] line 9-13) .

whereby the first and second dummy lines respectively absorb spurious noise emitted from the respective high speed signal lines (see paragraph [0071], lines 9-12 and paragraph [0003], lines 3-8 where in the ground lines which has function of electromagnetic shield can reduce the noise from the high speed signal line which is built in optical transceiver module).

Regarding to claim 3, Ido et al. discloses everything claimed as applied above (see claim 1). In addition, the optical transceiver includes:

wherein the first dummy ground line (ground pin 6-3-see [0049] line16 and FIG.2) is located between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the ground pin 6-3 is placed between a microstrip line 3-9 and the electrode pattern 3-11); and

the second dummy ground line (lead 6-4-see [0079] line 8 and FIG.9) is located between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which lead 6-4 is placed between around the perimeter of a strip line 3-9 and the electrode pattern 3-12).

Regarding to claim 4, Ido et al. discloses everything claimed as applied above (see claim 1). In addition, the optical transceiver includes:

wherein the light transmitting device (a LD module-see [0048] line 1 and FIG.1) is a laser diode (a laser diode (LD) element 9-see [0048] line2 and FIG.1) and the light receiving device (PD module-see [0079] line 2 and FIG.9) is a photo diode (PD element 10-see [0079] line 3 and FIG.9).

Regarding to claim 6, Ido et al. discloses everything claimed as applied above (see claim 1). In addition, the optical transceiver includes:

wherein the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device is located between the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) and also (see FIG2 in which a microstrip line 3-9 is placed between the ground pin 6-1 and the electrode pattern 3-11) ; and

the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device is located between the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) and also (see FIG.9 in which a strip line 3-9 is placed between around the perimeter of lead 6-2 and the electrode pattern 3-12).

Regarding to claim 8, Ido et al. discloses everything claimed as applied above (see claim 6). In addition, the optical transceiver includes:

wherein the first (ground pin 6-1-see [0049] line 16 and FIG.2) and the second dummy ground lines (lead 6-2-see [0079] line 8 and FIG.9) are located outside the photoelectric transducer (see FIG 2 and FIG 9 in which both ground lines are placed outside the LD module and PD module); and

the bias lines (electrode pattern 3-11-see [0070] line 4 and FIG.2 and the electrode pattern 3-12-see [0079] line 14 and FIG.9)) for the light transmitting device and the light receiving device are located inside the photoelectric transducer (see FIG.2 and FIG.9 in which both bias lines are placed inside the LD module and PD module).

Regarding to claim 9, Ido et al. discloses everything claimed as applied above (see claim 1). In addition, the optical transceiver includes:

wherein the photoelectric transducer (LD module-see [0019] line 1 and FIG. 2) further comprises a monitor photo detector (MPD) (a monitor PD element 10-see [0068] line 2) and a monitor photo detector (MPD) signal line for monitoring optical power of the light transmitting device (see [0068] line 2-3).

Regarding to claim 10, Ido et al. discloses everything claimed as applied above (see claim 9). In addition, the optical transceiver includes:

wherein the first dummy ground line (ground pin 6-3-see [0049] line16 and FIG.2) is located between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the ground pin 6-3 is placed between a microstrip line 3-9 and the electrode pattern 3-11); and

the second dummy ground line (lead 6-4-see [0079] line 8 and FIG.9) is located between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which lead 6-4 is placed between around the perimeter of a strip line 3-9 and the electrode pattern 3-12).

Regarding to claim 11, Ido et al. discloses everything claimed as applied above (see claim 9). In addition, the optical transceiver includes:

wherein the light transmitting device (a LD module-see [0048] line 1 and FIG.1) is a laser diode (a laser diode (LD) element 9-see [0048] line2 and FIG.1) and the light receiving device (PD module-see [0079] line 2 and FIG.9) is a photo diode (PD element 10-see [0079] line 3 and FIG.9).

Regarding to claim 13, Ido et al. discloses everything claimed as applied above (see claim 9). In addition, the optical transceiver includes:

wherein the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device is located between the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) and also (see FIG2 in which a microstrip line 3-9 is placed between the ground pin 6-1 and the electrode pattern 3-11); and

the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device is located between the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) and also (see FIG.9 in which a strip line 3-9 is placed between around the perimeter of lead 6-2 and the electrode pattern 3-12).

Regarding to claim 14, Ido et al. discloses everything claimed as applied above (see claim 13). In addition, the optical transceiver includes:

wherein the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) is less than or equal to the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the distance between a

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microstrip line 3-9 and ground pin 6-1 is smaller than the distance between a microstrip line 3-9 and electrode pattern 3-11); and

the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) is less than or equal to the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which the distance between a strip line 3-9 and lead 6-2 is smaller than the distance between the perimeter of a strip line 3-9 and the electrode pattern 3-12).

Regarding to claim 15, Ido et al. discloses everything claimed as applied above (see claim 13). In addition, the optical transceiver includes:

wherein the first (ground pin 6-1-see [0049] line 16 and FIG.2) and the second dummy ground lines (lead 6-2-see [0079] line 8 and FIG.9) are located outside the photoelectric transducer (see FIG 2 and FIG 9 in which both ground lines are placed outside the LD module and PD module); and

the bias lines (electrode pattern 3-11-see [0070] line 4 and FIG.2 and the electrode pattern 3-12-see [0079] line 14 and FIG.9)) for the light transmitting device and the light receiving device are located inside the photoelectric transducer (see FIG.2 and FIG.9 in which both bias lines are placed inside the LD module and PD module).

Regarding to claim 16, Ido et al. discloses everything claimed as applied above (see claim 1). In addition, the optical transceiver includes:

a package encapsulant (the metal cap5-see [0051] line6 and FIG.1) attached to the substrate (see [003] line 32 and FIG.1 where in the metal cap is joined to the substrate);

a leadframe pad (the electrode pattern 3-0-see[0051] line 7 and FIG.1) located inside the package encapsulant(see FIG.1 where in the electrode pattern is placed inside the metal cap); and

a plurality of leadframes (lead pins 6-1 through 6-8-see FIG.2 and FIG.9) connected to the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device, the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device, the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device, the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device, the first dummy ground line, the second dummy ground line, and the leadframe pad (the electrode pattern 3-0-see[0051] line 7 and FIG.1) and also (see FIG.2 and FIG.9 where in the lead pins are connected to microstrip line 3-9, electrode pattern 3-11, a strip line 3-9 and the electrode pattern 3-12) , respectively.

Regarding to claim 17, Ido et al. discloses everything claimed as applied above (see claim 16). In addition, the optical transceiver includes:

wherein the first dummy ground line (ground pin 6-3-see [0049] line16 and FIG.2) is located between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the ground pin 6-3 is placed between a microstrip line 3-9 and the electrode pattern 3-11); and

the second dummy ground line (lead 6-4-see [0079] line 8 and FIG.9) is located between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which lead 6-4 is placed between around the perimeter of a strip line 3-9 and the electrode pattern 3-12).

Regarding to claim 18, Ido et al. discloses everything claimed as applied above (see claim 16). In addition, the optical transceiver includes:

wherein the light transmitting device (a LD module-see [0048] line 1 and FIG.1) is a laser diode (a laser diode (LD) element 9-see [0048] line2 and FIG.1) and the light receiving device (PD module-see [0079] line 2 and FIG.9) is a photo diode (PD element 10-see [0079] line 3 and FIG.9).

Regarding to claim 20, Ido et al. discloses everything claimed as applied above (see claim 16). In addition, the optical transceiver includes:

wherein the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device is located between the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) and also (see FIG2 in which a microstrip line 3-9 is placed between the ground pin 6-1 and the electrode pattern 3-11) ; and

the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device is located between the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) and also (see FIG.9 in which a strip line 3-9 is placed between around the perimeter of lead 6-2 and the electrode pattern 3-12).

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

4. **Claim 1** is rejected under 35 U.S.C. 103(a) as being unpatentable over Ido et al. (US Pub Number 2002/0181853) in view of Nakanishi et al. (US Pub Number 2002/0071641).

Regarding to claim 1, Ido et al. discloses an optical transceiver (see [0114] lines 2 and FIG.19), comprising:

a photoelectric transducer (LD module-see [0019] line 1 and FIG. 2) implemented on a substrate (a silicon sub-mount 8-see [0050] line2 and FIG. 2) and having a light transmitting device (a laser diode(LD) element 9-see [0048] line 2 and FIG.2) for converting an electrical signal into a light signal (see [0048] line 2-3) , a high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device, a bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device spaced from the high speed signal line for the light transmitting device (see FIG.2 where in the electrode pattern 3-11 has space from the microstrip line 39 for transmitting device), a light receiving device (PD element 10-see [0079] line 3 and FIG.9) for converting the light signal into the electrical signal (see [0079] lines 1-3) , a high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light

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receiving device, a bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device spaced from the high speed signal line for the light receiving device (see FIG.9 where in the electrode pattern 3-12 has space from the strip line 39 for receiving device), a first dummy ground line (ground pin 6-3-see [0049] line16 and FIG.2) located adjacent to the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device, and a second dummy ground line (lead 6-4-see [0079] line 8 and FIG.9) located adjacent to the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device;

wherein the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the first dummy ground line (ground pin 6-1-see [0049] line16 and FIG.2) is less than or equal to the space between the high-speed signal line (a microstrip line 3-9-see [0049] line5 and FIG.2) for the light transmitting device and the bias line (electrode pattern 3-11-see [0070] line 4 and FIG.2) for the light transmitting device (see FIG.2 in which the distance between a microstrip line 3-9 and ground pin 6-1 is smaller than the distance between a microstrip line 3-9 and electrode pattern 3-11); and the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the second dummy ground line (lead 6-2-see [0079] line 8 and FIG.9) is less than or equal to the space between the high-speed signal line (a strip line 3-9-see [0079] line 7 and FIG.9) for the light receiving device and the bias line (the electrode pattern 3-12-see [0079] line 14 and FIG.9) for the light receiving device (see FIG.9 in which the distance

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between a strip line 3-9 and lead 6-2 is smaller than the distance between the perimeter of a strip line 3-9 and the electrode pattern 3-12) and

a light signal transmitter (a LD driver IC 112-see [0114] line 7 and FIG.19) connected to the photoelectric transducer (a LD module-see [0114] line 2 and FIG.19), transmitting a light signal received from an optical fiber to the light receiving device (see [0114] lines 13-17 in which light transmits from LD module which enters into the fiber first and then is received by PD module), and transmitting a light signal generated from the light transmitting device to the optical fiber (see [0014] line 9-13) .

whereby the first and second dummy lines respectively absorb spurious noise emitted from the respective high speed signal lines (see paragraph [0071], lines 9-12 and paragraph [0003], lines 3-8 where in the ground lines which has function of electromagnetic shield can reduce the noise from the high speed signal line which is built in optical transceiver module).

Ido et al. teaches ground pin, which has the function of electromagnetic shield, can reduce the optical module's noise. Additionally, Nakanishi et al. also teaches that when metal shield plate is grounded to the ground pin, the ground pin can absorb the electromagnetic noise, which cause electric cross talk for the optical transceiver (see paragraph [0007], lines 1-10).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time the invention was made to combine Ido et al with Nakanishi et al. for the purpose of any types of shield plate connected to the ground pin has the ability of

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absorbing the noise characteristic which cause in an optical transceiver module for preventing from the electric cross talk of the module.

5. **Claims 2** is rejected under 35 U.S.C. 103(a) as being unpatentable over Ido et al. (US Pub Number 2002/0181853) in view of Ido et al. (US Pub Number 2003/0194192).

Regarding to claim 2, Ido et al. discloses everything claimed as applied above (see claim 1). However he fails to disclose what is the silicon substrate made of for better operating in optical communication.

Ido et al. (US Pub Number 2003/0194192). teaches the optical transceiver includes wherein the substrate (see [0027] line 15) is composed of a silicon substrate (see [0027] line 16) having a silicon oxide film (see [0027] line 16).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify Ido et al.'s invention as making the silicon substrate with the silicon oxide film on top of silicon substrate instead of using other chemical materials because insulation film of silicon oxide would not allow the current flow in the electrode of the photodiode and silicon oxide film itself has its own capacitance.

6. **Claim 5,12 and 19** are rejected under 35 U.S.C. 103(a) as being unpatentable over Ido et al. (US Pub Number 2002/0181853) in view of Terada et al. (US Pub Number 2002/0027230)

Regarding to claim 5, Ido et al. discloses everything claimed as applied above (see claim 1). However he fails to disclose the optical transceiver has a planar lightwave circuit for all optical components are mounted on a common substrate to get efficiency coupling power to each other.

Terada et al. discloses where in the light signal transmitter (LED 12-see [0057] line 4) is composed of a planar lightwave circuit (PLC) (see [0029] lines1-3).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify Ido et al.'s invention as mounting the planar lightwave circuit on the substrate instead of using separate optical module circuits on substrate because the PLC platform hybrid integration circuit sets up all optical components on a common substrate and it makes optical coupling among them firm and stable against temperature variation. On the other hand, the integration of LD and PD to a common substrate increases optical and electrical coupling between them.

Regarding to claim 12, Ido et al. discloses everything claimed as applied above (see claim 9). However he fails to disclose the optical transceiver has a planar lightwave circuit for all optical components are mounted on a common substrate to get efficiency coupling power to each other.

Terada et al. discloses where in the light signal transmitter (LED 12-see [0057] line 4) is composed of a planar lightwave circuit (PLC) (see [0029] lines1-3).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify Ido et al.'s invention as mounting the planar lightwave circuit on the substrate instead of using separate optical module circuits on substrate because the PLC platform hybrid integration circuit sets up all optical components on a common substrate and it makes optical coupling among them firm and stable against temperature variation. On the other hand, the integration of LD and PD to a common substrate increases optical and electrical coupling between them.

Regarding to claim 19, Ido et al. discloses everything claimed as applied above (see claim 16). However he fails to disclose the optical transceiver has a planar lightwave circuit for all optical components are mounted on a common substrate to get efficiency coupling power to each other.

Terada et al. discloses where in the light signal transmitter (LED 12-see [0057] line 4) is composed of a planar lightwave circuit (PLC) (see [0029] lines1-3).

Therefore, it would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify Ido et al.'s invention as mounting the planar lightwave circuit on the substrate instead of using separate optical module circuits on substrate because the PLC platform hybrid integration circuit sets up all optical components on a common substrate and it makes optical coupling among them firm and stable against temperature variation. On the other hand, the integration of LD and PD to a common substrate increases optical and electrical coupling between them.

Citation of Pertinent Prior Art

7. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Kuhara et al. (US Patent Number 6614964) discloses an apparatus for including a transmitter and receiver modules help reducing electrical cross talk and noise during operation.

Nakanishi et al. (US Patent Number 6318908) discloses light transmitting and receiving module having a silicon substrate, fiber waveguide and filtering circuit for better optical communication.

Nakanishi et al. (US Patent Number 6374021) discloses LD /PD module which includes two fiber waveguides, laser diode, photo diode and monitoring photo diode for advanced optical communication.

Response to Arguments

8. Applicant's arguments filed April 19,2007 have been fully considered but they are not persuasive.

9. Applicant argues that the applied prior art to Ido et al. teaches that ground pin performs as an electromagnetic shield function as part of signal line for transmitting signal and Ido et al. fail to disclose the dummy ground lines are absorbing noise that is generated in transmitting signal in order to maintain and keep stable the transmission of signals for amended claim 1 and original claim 1. This argument is not persuasive since Applicant's original claim 1 failed to recite such a limitation. While claims are read in

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light of the specification, absent any explicit and deliberate definitions, limitations from the specification are not to be read into the claim. Applicant has provided no such explicit and deliberate definitions. Thus, Applicant's arguments are more specific than what original claim 1 require.

New amended claim 1 recites the use of dummy ground line, which can absorb noise that is generated in transmitting signal in order to maintain and keep stable the transmission of signal are addressed in the new grounds of rejection under 102 and 103 rejection above.

10. With respect to the claim 2, Applicant argues that both disclosures Ido et al. ('853) and Ido et al. ('192) fail to teach that the substrate is composed of a silicon substrate having a silicon oxide film.

In response this Applicant argument that Ido et al. ('192) explicitly disclose that a silicon substrate provided with a silicon oxide layer (see [0027], line 16-17).

11. With respect to claims 5,12 and 19, Applicant argues that both Ido et al ('853) and Terada et al. ('230) do not teach the silicon substrate composed of silicon oxide.

In response this Applicant argument that based on claims 5,12 and 19 the claim limitation is directed to light signal transmitter is composed of a planar lightwave circuit (PLC) instead of the claim limitation is directed to silicon substrate. Thus, Applicant's argument is not relying on the existing claim's limitation.

Conclusion

12. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire **THREE MONTHS** from the mailing date of this action. In the event a first reply is filed within **TWO MONTHS** of the mailing date of this final action and the advisory action is not mailed until after the end of the **THREE-MONTH** shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than **SIX MONTHS** from the date of this final action.

13. Any inquiry concerning this communication or earlier communications from the examiner should be directed to PHYOWAI LIN whose telephone number is (571) 270-1659. The examiner can normally be reached on Monday through Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Kenneth Vanderpuye can be reached on (571) 272-3078. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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PWL


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